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|-----------------------------------|--|-------------------------|---|--|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/017,031 | KISS, DAVID A. | |
| Examiner | | Art Unit | S. V. Clark | |
| | | 2815 | Page 1 of 1 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | A | US-6,853,064 | 02-2005 | Bolken et al. | 257/686 |
| | B | US-6,787,916 | 09-2004 | Halahan, Patrick B. | 257/777 |
| | C | US-6,787,901 | 09-2004 | Reyes et al. | 257/724 |
| | D | US-6,781,226 | 08-2004 | Huppenthal et al. | 257/686 |
| | E | US-6,737,750 | 05-2004 | Hoffman et al. | 257/777 |
| | F | US-6,461,897 | 10-2002 | Lin et al. | 438/109 |
| | G | US-6,359,340 | 03-2002 | Lin et al. | 257/777 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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